CORRECTION



Correction to: The Role of the Substrate on Photophysical Properties of Highly Ordered 15R-SiC Thin Films

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Correction to: Journal of ELECTRONIC MATERIALS, Vol. 47, No. 9, 2018 https://doi.org/10.1007/s11664-018-6411-6

The wrong issue and volume number are indicated on the published article. This article appears in Volume 47, Number 9.

Published online September 21, 2018 The original article can be found online at https://doi.org/10.1007/ s11664-018-6411-6.